Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	75	marangoni and megaso\$	USPAT	OR	OFF	2004/12/10 12:26
L2	1	"6726848".pn.	USPAT	OR	OFF	2004/12/10 12:27
L3	9	("5017236" "5090432" "5601655" "6006765" "6192600" "6240938" "6273100" "6311702" "6328814").PN.	US-PGPUB; USPAT; USOCR	OR	OFF	2004/12/10 12:27
L4	0	("6726848").URPN.	USPAT	OR	OFF	2004/12/10 12:38
L5 .	1	"6726848"	DERWENT	ADJ	OFF	2004/12/10 13:33

DERWENT-ACC-NO: 2003-523443

DERWENT-WEEK: 200466

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TITLE:

Treatment of substrates by enclosing one or

two

substrates within process chamber, exposing

substrates to

first process fluid, then exposing substrates

to second

process fluid

INVENTOR: BLECK, M; HANSEN, E; MIMKEN, V; ROSATO, J; YALAMANCHILI, RM

; YALAMANCHILI, M R

PATENT-ASSIGNEE: SCP GLOBAL TECHNOLOGIES INC[SCPGN] , BLECK M[BLECI], HANSEN

E[HANSI], MIMKEN V[MIMKI], ROSATO J[ROSAI], YALAMANCHILI M R[YALAI]

PRIORITY-DATA: 2001US-0010240 (December 7, 2001) , 2004US-0826458 (April 16, 2004)

PATENT-FAMILY:

PUB-NO		PUB-DATE	LANGUAGE
PAGES	MAIN-IPC		
US 20040198	3051 A1	October 7, 2004	N/A
000	H01L 021/302		
WO 20030508	361 A1	June 19, 2003	E
075	H01L 021/306		
US 20030205559 A1		November 6, 2003	N/A
000	C23F 001/00		
AU 2002362092 A1		June 23, 2003	N/A
000	H01L 021/306		
US 6726848	B2	April 27, 2004	N/A
000	H01L 021/00		
EP 1454350	A1	September 8, 2004	E
000	H01L 021/306		

DESIGNATED-STATES: AE AG AL AM AT AU AZ BA BB BG BR BY BZ CA CH CN CO CR CU CZ

DE DK DM DZ EC EE ES FI GB GD GE GH GM HR HU ID IL IN IS JP KE KG KP KR KZ LC

LK LR LS LT LU LV MA MD MG MK MN MW MX MZ NO NZ OM PH PL PT RO RU SD

SE SG SK

SL TJ TM TN TR TT TZ UA UG US UZ VN YU ZA ZM ZW AT BE BG CH CY CZ DE

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ES FI FR GB GH GM GR IE IT KE LS LU MC MW MZ NL OA PT SD SE SI SK SL

SZ TR TZ

UG ZM ZW AL AT BE BG CH CY CZ DE DK EE ES FI FR GB GR IE IT LI LT LU

LV MC MK

NL PT RO SE SI SK TR

APPLICATION-DATA:

PUB-NO	APPL-DESCRIPTOR	APPL-NO
APPL-DATE		
US20040198051A1	Cont of	2001US-0010240
December 7, 2001		
US20040198051A1	N/A	2004US-0826458
April 16, 2004		
US20040198051A1	Cont of	US <u>6726848</u>
N/A		
WO2003050861A1	N/A	2002WO-US39174
December 6, 2002		
US20030205559A1	N/A	2001US-0010240
December 7, 2001		
AU2002362092A1	N/A	2002AU-0362092
December 6, 2002		
AU2002362092A1	Based on	WO2003050861
N/A		
US 6726848B2	N/A	2001US-0010240
December 7, 2001		
EP 1454350A1	N/A	2002EP-0797224
December 6, 2002		
EP 1454350A1	N/A	2002WO-US39174
December 6, 2002		
EP 1454350A1	Based on	WO2003050861
N/A		

INT-CL (IPC): B08B003/00, B08B003/000, B44C001/22, C03C015/00,
C03C025/68, C23F001/00, C25F003/00, H01L021/00, H01L021/302,
H01L021/306, H01L021/461

ABSTRACTED-PUB-NO: WO2003050861A

BASIC-ABSTRACT:

NOVELTY - Substrates are individually treated by:

(a) providing a process chamber proportioned to enclose not more than two substrates at a time and enclosing one or two substrates within the process

chamber;

(b) exposing the substrates to a first process fluid within the process chamber; and

(c) exposing the substrate to a second process fluid within the process chamber.

DETAILED DESCRIPTION - An INDEPENDENT CLAIM is also included for a substrate

treatment apparatus comprising a process chamber, a source of first process

fluid coupled to the process chamber and a source of second process fluid $% \left(\frac{1}{2}\right) =\frac{1}{2}\left(\frac{1}{2}\right) +\frac{1}{2}\left(\frac{1}{2}\right) +\frac$

coupled to the process chamber.

USE - Used for individually treating substrates.

ADVANTAGE - The process enables higher precision processing compared to batch

processing. Each substrate is exposed to process fluids for a shorter time $% \left(1\right) =\left(1\right) +\left(1\right)$

than that which is required in batch processing.

DESCRIPTION OF DRAWING(S) - The figure shows a single substrate processing chamber.

Megasonic transducers 32a, 32b

CHOSEN-DRAWING: Dwg.1E/9

TITLE-TERMS: TREAT SUBSTRATE ENCLOSE ONE TWO SUBSTRATE PROCESS CHAMBER EXPOSE

SUBSTRATE FIRST PROCESS FLUID EXPOSE SUBSTRATE SECOND PROCESS FLUID

DERWENT-CLASS: LO3 P43 P78 U11

CPI-CODES: L04-C07C1; L04-D03;

EPI-CODES: U11-C06A1B; U11-C07B;

SECONDARY-ACC-NO:

CPI Secondary Accession Numbers: C2003-140943 Non-CPI Secondary Accession Numbers: N2003-415291

WEST Search History

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DATE: Friday, December 10, 2004

Hide? <u>Set Name</u> <u>Query</u>			Hit Count
	DB=US	SPT; PLUR=YES; OP=AD.	J
	L3	L2 and wafer	74
	L2	marangoni and megaso\$	75
	L1	marangoni nad megaso\$	0

END OF SEARCH HISTORY

D Fr12 Ti



PALM INTRANET

Inventor Name Search Result

Your Search was:

Last Name = CAWLFIELD

First Name = B.

Application#	Patent#	Status	Date Filed	Title	Inventor Name 4
10064571	Not Issued	030	07/26/2002	MEGASONICALLY ENERGIZED LIQUID INTERFACE APPARATUS AND METHOD	CAWLFIELD, B. GENE
08417462	Not Issued	161	04/05/1995	CONTROLLED FLUID AGITATION METHOD AND APPARATUS	CAWLFIELD , B. GENE
08120598	Not Issued	161	09/13/1993	CONTROLLED FLUID AGITATION METHOD AND APPARATUS	CAWLFIELD , B. GENE
<u>07676272</u>	5246025	150	03/28/1991	CONTROLLED FLUID AGITATION METHOD AND APPARATUS	CAWLFIELD , B. GENE

Inventor Search Completed: No Records to Display.

Saarah Amathan	Last Name	First Name	
Search Another:	CAWLFIELD	B.	
Inventor	,	Search	

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